

In the Specification

Amend the specification as follows:

Amend the paragraph beginning at page 6, line 7 as follows:

More preferably, the second grid pattern period ~~pis-~~ p is defined by the expression:

Amend the paragraph beginning at page 21, line 9 as follows:

A general flowchart 100 of the overlay error extraction method that we have examined in the example above, is shown in Fig. 14. In the first step 102, the target image is scanned in the x- and y-directions to produce a digitized target image $I(x, y)$ with a pixel size much smaller than the magnified sub-grid period $M \times p$. The (x, y) scanned intensities are then integrated 104 into intensities $I_n(x)$ and $I_m(y)$. The integrated intensities are then separated 106 into single frame intensities $I_{nm}(x)$ and $I_{nm}(y)$. The single frame intensities are then aligned 108 using reference signals $I_R(x)$ and $I_R(y)$ common to each target frame. The $I_F(x)$ and $I_F(y)$ intensities are then fit 110 to sinusoids in each frame to determine the parameters A , B , d and s , where parameter d is the ratio of pixel size c to sub-grid period p and parameter s measures the center of the sinusoidal patterns.